

**Notice of References Cited**

Application/Control No.

09/095,678

Applicant(s)/Patent Under  
Reexamination  
NAKAYAMA ET AL.

Examiner

John M. Villecco

Art Unit

2612

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,097,340 ✓	03-1992	Tanabe et al.	348/296
	B	US-4,805,037 ✓	02-1989	Noble et al.	348/371
	C	US-5,946,035 ✓	08-1999	Suh, Inh-seok	348/371
	D	US-4,593,312 ✓	06-1986	Yamasaki, Masafumi	348/371
	E	US-4,768,876 ✓	09-1988	Okino, Tadashi	348/229.1
	F	US-5,097,340 ✓	03-1992	Tanabe et al.	348/296
	G	US-5,438,367 ✓	08-1995	Yamamoto et al.	348/371
	H	US-5,517,243 ✓	05-1996	Kudo et al.	348/296
	I	US-5,006,871 ✓	04-1991	Noble, Stephen A.	348/64
	J	US-5,956,535 ✓	09-1999	Tohyama, Kei	315/241P
	K	US-6,049,355 ✓	04-2000	Kameyama, Takashi	348/222.1
	L	US-5,936,708 ✓	08-1999	Saita, Hirofumi	347/226
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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